



	<b>Experiment title:</b> GISAXS study of sub-10 nm scale nano-organization in the thin films made from oligosaccharide-containing block copolymer system	<b>Experiment number:</b> 02-01-877
<b>Beamline:</b>	<b>Date of experiment:</b> from: 16/11/2016 to: 18/11/2016	<b>Date of report:</b> 09/02/2017
<b>Shifts:</b>	<b>Local contact(s):</b> Nathalie Boudet (email: boudet@esrf.fr) Nils Blanc (email: d2am@esrf.fr)	<i>Received at ESRF:</i>
<b>Names and affiliations of applicants (* indicates experimentalists):</b>  Issei Otsuka* (CERMAV) Laurent Goujon* (CERMAV) Yingjie Liao* (CERMAV) Takuya Isono* (CERMAV) Yoko Otsuka (CERMAV) Redouane Borsali (CERMAV)		

## Report:

### 1. Background and aim of the experiments

Over the past few decades, block copolymers (BCPs) have received considerable attention as a promising platform for the synthesis of nanomaterials and fabrication of nanostructures due to their self-assembling nature into nanometer-scale periodic domains whether in the bulk or solution states. Preparing novel bio-based “hybrid” BCP systems and investigating their self-assembly properties represent a step forward towards new class of nanomaterials. Strong repulsions between natural saccharidic blocks and synthetic blocks, expressed by the Flory-Huggins parameter, enable reducing inter-domain size of nano-organized morphologies toward sub-10 nm scale. Indeed, we have reported the first nano-organized glyco thin film of the BCP (polystyrene-*b*-maltoheptaose: PS-*b*-MH) in sub-10 nm feature sizes, whose morphologies were precisely investigated by microscopy, SAXS and preliminary GISAXS using ESRF synchrotron beam line D2AM.

The aims of the experiments direct morphological characterization of the self-assembled thin films of oligosaccharide-based hybrid BCPs on silicon substrates by GISAXS technique. Generally, the morphologies of self-assembled BCPs (lamellae, gyroid, cylinder, sphere, etc.) have been characterized by combining scattering analysis (SAXS/WAXS) of the bulk polymers and microscopic analysis (AFM/TEM/SEM) of the thin films. However, the self-assembled morphologies of BCPs at the surfaces of the thin films are not same as those in bulk, i.e. the presence of two interfaces, air-film and film-substrate, could induce preferential order in the

film, such as lateral and normal ordering to the surfaces. GISAXS technique can provide such a 3D ordered morphological information at the surface or inside of the thin film, which is very important when the BCP thin films are used for nanolithography.

## 2. Experiments

GISAXS experiments have been performed on thin films made from various BCPs investigating several key parameters leading to the nano-organization such as i) the nature of the blocks, ii) the solvent vapor annealing conditions, iii) the use of a new promising microwave assisted solvent annealing route and iv) the silicon surface energies after chemical functionalizations. Scattered intensities have been recorded at room temperature during 10-100 sec exposures on a CCD detector placed in some distance from the sample holder depending on the required  $q$  range, and for incidence angles between  $0.10^\circ$  and  $0.22^\circ$  with  $0.02^\circ$  steps.

## 3. Result and discussion

The AFM and GISAXS images of maltoheptaose-*b*-polystyrene (MH-*b*-PS) 40 nm thin films coated onto plasma treated silicon wafers and annealed with THF/H<sub>2</sub>O (w/w) for 22h were shown in Figure 1. According to the GISAXS patterns, the nano-organization seems switch from horizontal cylinders ( $C_{//}$ ) to vertical cylinders ( $C_{\perp}$ ) when the THF/H<sub>2</sub>O ratio increases from 1/1 to 15/1, and then turn to spheres (S) for pure THF annealing.

For each samples, domain spacings between 10 and 12 nm have been extracted from the distinct primary scattering peak ( $q^*$ ) along the GISAXS  $q_y$  profile at the Yoneda peak and are in good agreement with the preliminary AFM and SAXS experiments. Higher-order scattering peaks can be observed, e.g. at  $2q^*$  (Figure 1 e and g), but some are missing, especially at  $2^{1/2}q^*$  and  $3^{1/2}q^*$ , which adds difficulties in the GISAXS data interpretations. Therefore the GISAXS pattern of what can be a mixture of  $C_{//}$  and  $C_{\perp}$  (figure 1 f) appears quite close of the pattern of what we estimate to be S (figure 1 h). The GISAXS image for the THF/H<sub>2</sub>O 15/1 annealing (figure 1 g) is also tricky to interpret and could be  $C_{\perp}$  as well as S in BCC arrangement. These states of uncertainty can be overcome by extra GISAXS measurements (e.g. recording at different rotation angles along the perpendicular axis to the sample) and maybe GISAXS simulations.

## 4. Conclusion

From these preliminary experiments, we obtained confirmation that GISAXS at BM02 is a powerful technics to study our systems. More experiments are needed to discriminate  $C_{\perp}$  of S and to go further in details, getting more information about the cylinders orientation all along the film cross-section and the effect of the substrate surface properties on these orientations. We also prospect for help in the data treatment and simulation.

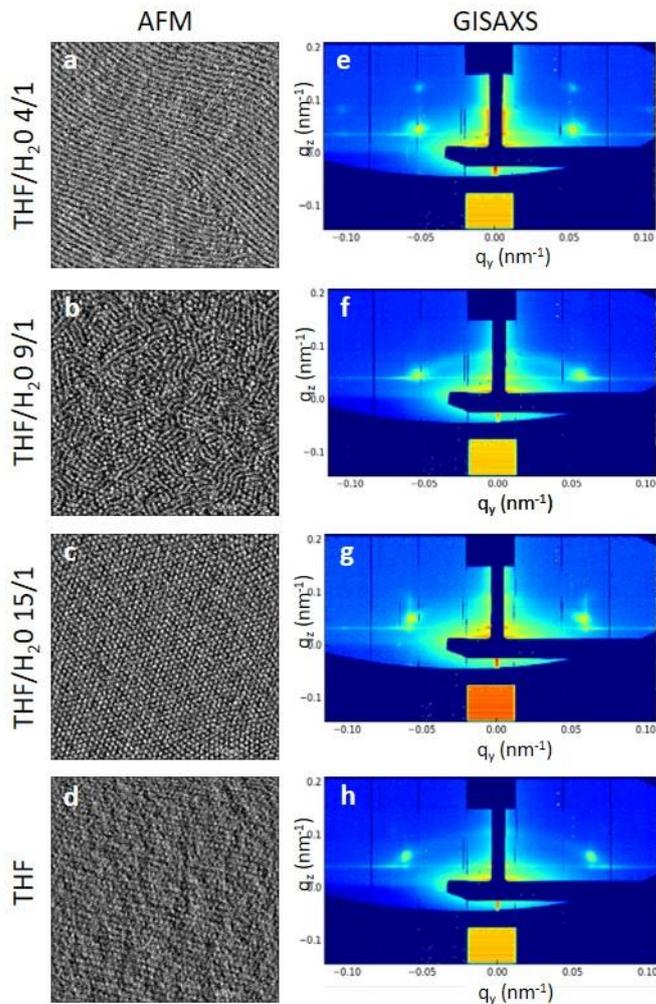


Figure 1: AFM phase (a-d) and GISAXS (e-h for an incidence angle of  $0.14^\circ$ ) images of MH-*b*-PS according to the solvent vapor annealing conditions.